

MOSFET - N-Channel, Logic Level, POWERTRENCH®

60 V, 80 A, 6 m Ω

FDP5800

Description

This N-Channel MOSFET is produced using **onsemi**'s advanced POWERTRENCH process that has been tailored to minimize the on-state resistance while maintaining superior switching performance.

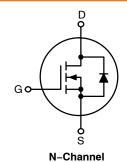
Features

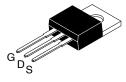
- $R_{DS(on)} = 4.6 \text{ m}\Omega \text{ (Typ.)} @ V_{GS} = 10 \text{ V}, I_D = 80 \text{ A}$
- High Performance Trench Technology for Extremely Low R_{DS(on)}
- Low Gate Charge
- High Power and Current Handling Capability
- RoHS Compliant

Applications

- Power Tools
- Motor Drives and Uninterruptible Power Supplies
- Synchronous Rectification
- Battery Protection Circuit

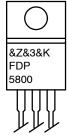
V _{DS}	R _{DS(on)} MAX I _D MAX	
60 V	6 mΩ @ 10 V	80 A





TO-220-3LD CASE 340AT

MARKING DIAGRAM



&Z = Assembly Plant Code &3 = 3-Digit Date Code &K = 2-Digits Lot Run Code FDP5800 = Specific Device Code

ORDERING INFORMATION

Device	Package Shipping	
FDP5800	TO-220-3LD	800 Units / Tube

MOSFET MAXIMUM RATINGS (T_C = 25°C unless otherwise noted)

Symbol	Paramete	FDP5800	Unit	
V _{DSS}	Drain-Source Voltage		60	V
V _{GSS}	Gate-Source Voltage		±20	V
I _D	Drain Current	– Continuous (T _C = 25°C)	80	Α
		– Continuous (T _C = 100°C)	80*	1
		– Continuous (T _A = 25°C)	14	1
I _{DM}	Drain Current	- Pulsed	320	Α
E _{AS}	Single Pulsed Avalanche Energy (Note 1)		652	mJ
P_{D}	Power Dissipation	(T _C = 25°C)	242	W
		-Derate above 25°C	1.61	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range	•	-55 to +175	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.
*Drain current limited by package.

1. L = 1 mH, I_{AS} = 36 A, V_{DD} = 54 V, V_{GS} = 10 V, R_G = 25 Ω, starting T_J = 25°C

THERMAL CHARACTERISTICS

Symbol	Parameter	FDP5800	Unit
$R_{ heta JC}$	Thermal Resistance, Junction to Case, Max.	0.62	°C/W
$R_{ heta JA}$	Thermal Resistance, Junction to Ambient, Max.	62.5	

ELECTRICAL CHARACTERISTICS ($T_C = 25^{\circ}C$ unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
OFF CHAR	ACTERISTICS				•	
BV _{DSS}	Drain-Source Breakdown Voltage	$I_D = 250 \mu A$, $V_{GS} = 0 V$, $T_J = 25^{\circ}C$	60	_	_	V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 48 V, V _{GS} = 0 V	-	-	1	μΑ
		V _{DS} = 48 V, V _{GS} = 0 V, T _J = 150°C	-	-	500	
I _{GSS}	Gate-Body Leakage Current, Forward	V _{GS} = ±20 V, V _{DS} = 0 V	-	-	±100	nA
ON CHARA	CTERISTICS				•	
V _{GS(th)}	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	1.0	_	2.5	V
R _{DS(on)}	Static Drain-Source On Resistance	V _{GS} = 10 V, I _D = 80 A	-	4.6	6.0	mΩ
		V _{GS} = 4.5 V, I _D = 80 A	-	5.9	7.2	
		V _{GS} = 5 V, I _D = 80 A	-	5.6	7.0	
		V _{GS} = 10 V, I _D = 80 A, T _J = 175°C	-	10.4	12.6	
DYNAMIC (CHARACTERISTICS	•		•		
C _{iss}	Input Capacitance	V _{DS} = 15 V, V _{GS} = 0 V, f = 1 MHz	-	6890	9160	pF
C _{oss}	Output Capacitance		-	750	1000	pF
C _{rss}	Reverse Transfer Capacitance	1	-	295	445	pF
R _G	Gate Resistance	V _{GS} = 0.5 V, f = 1 MHz	-	1.2	-	Ω
Q _{g(TOT)}	Total Gate Charge at 10 V	$V_{GS} = 0 \text{ V to } 10 \text{ V}, V_{DS} = 30 \text{ V}, \\ I_D = 80 \text{ A}, I_g = 1 \text{ mA}$	-	112	145	nC
$Q_{g(TH)}$	Total Gate Charge at 5 V	V_{GS} = 0 V to 5 V, V_{DS} = 30 V, I_D = 80 A, I_g = 1 mA	-	58	-	nC
$Q_{g(TH)}$	Threshold Gate Charge	V_{GS} = 0 V to 1 V, V_{DS} = 30 V, I_D = 80 A, I_g = 1 mA	-	7.0	-	nC
Q _{gs}	Gate to Source Gate Charge	V _{DS} = 30 V, I _D = 80 A, I _g = 1 mA	-	23	_	nC
Q _{gs2}	Gate Charge Threshold to Plateau	1	-	13	-	nC
Q _{gd}	Gate to Drain "Miller" Charge	1	-	18	-	nC
SWITCHING	G CHARACTERISTICS (V _{GS} = 10 V)	•				
t _{ON}	Turn-On Time	$V_{DD} = 30 \text{ V}, I_D = 80 \text{ A}, V_{GS} = 10 \text{ V},$	-	37	85	ns
t _{d(on)}	Turn-On Delay Time	$R_G = 1.5 \Omega$	-	18	46	ns
t _r	Turn-On Rise Time	1	-	19	47	ns
t _{d(off)}	Turn-Off Delay Time	1	-	55	120	ns
t _f	Turn-Off Fall Time	1	-	9	28	ns
t _{OFF}	Turn-Off Time	1	-	64	138	ns
DRAIN-SO	URCE DIODE CHARACTERISTICS	•		-	-	
V _{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0 V, I _{SD} = 80 A	-	-	1.25	V
		V _{GS} = 0 V, I _{SD} = 40 A	-	-	1.0	V
t _{rr}	Reverse Recovery Time	$V_{GS} = 0 \text{ V}, I_{SD} = 60 \text{ A}, dI_F/dt = 100 \text{ A}/\mu\text{s}$	-	58	-	ns
Q _{rr}	Reverse Recovery Charge	1	_	106	_	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

TYPICAL PERFORMANCE CHARACTERISTICS

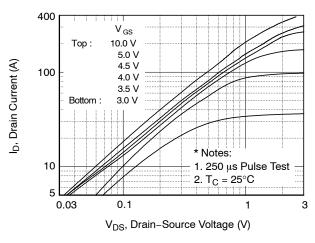


Figure 1. On-Region Characteristics

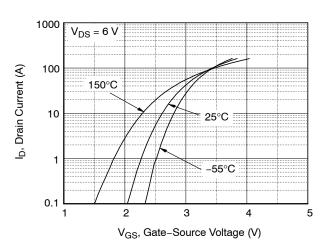


Figure 2. Transfer Characteristics

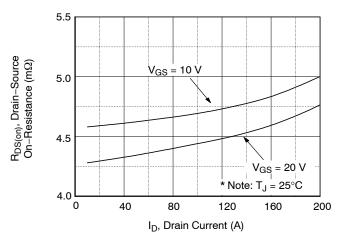


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

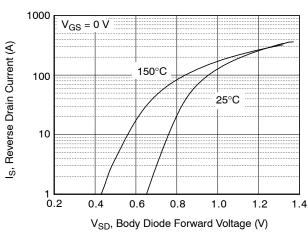


Figure 4. Body Diode Forward Voltage Variation vs. Source Current And Temperature

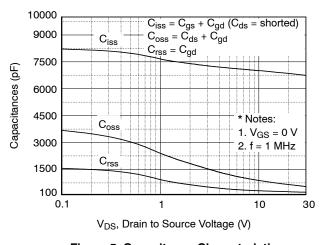


Figure 5. Capacitance Characteristics

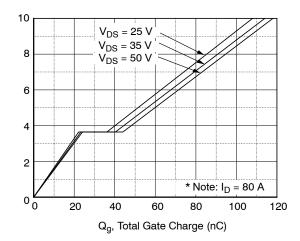


Figure 6. Gate Charge Characteristics

V_{GS}, Gate-Source Voltage (V)

TYPICAL PERFORMANCE CHARACTERISTICS (continued)

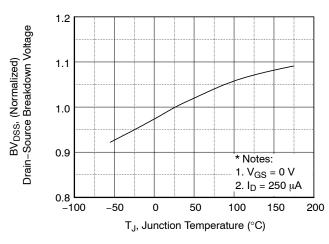
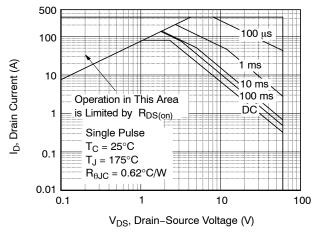


Figure 7. Breakdown Voltage Variation vs. Temperature

Figure 8. On–Resistance Variation vs. Temperature



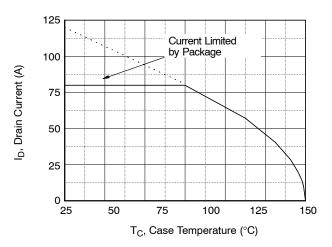


Figure 9. Maximum Safe Operating Area

Figure 10. Maximum Drain Current vs.

Case Temperature

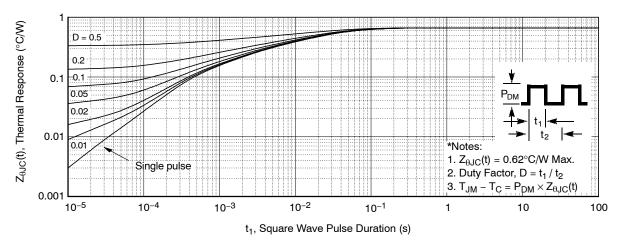


Figure 11. Transient Thermal Response Curve

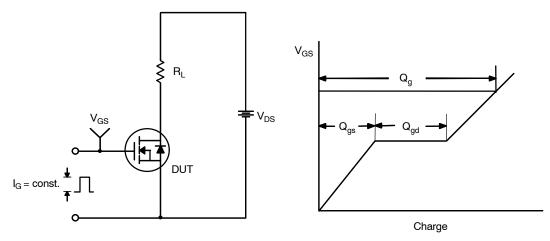


Figure 12. Gate Charge Test Circuit & Waveform

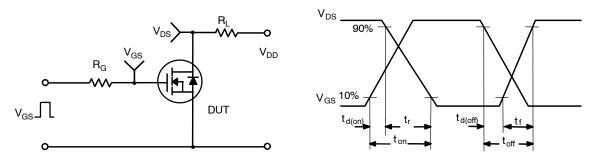


Figure 13. Resistive Switching Test Circuit & Waveforms

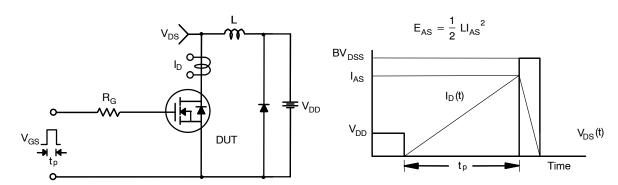


Figure 14. Unclamped Inductive Switching Test Circuit & Waveforms

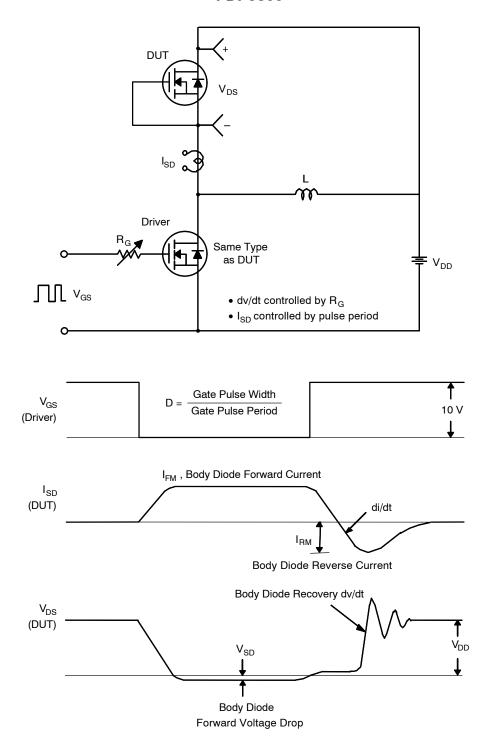


Figure 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms

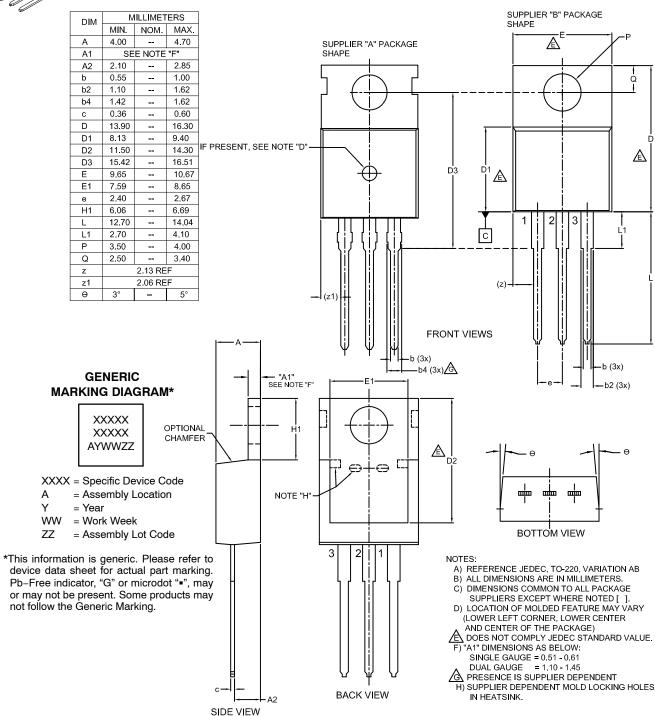
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